

**Thermal Cycling** 

(Version 2.6, 06 June 2017)

# **Objective and Scope**

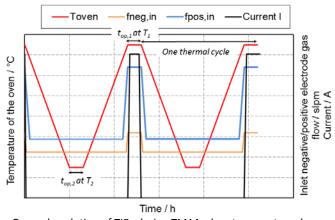
This test module deals with thermal cycling of solid oxide cell (SOC) either as a fuel cell (SOFC) or an electrolyser (SOEC), composed of several start-up/shut-down occurring for the overall SOC lifetime. It is a general characterization method that can be used in SOC R&D and for quality assurance.

## Main Test Input Parameters (TIPs)

Static TIPs	Variable TIPs
Rate of oven temperature change $(\Delta T_{oven}/\Delta t)$	Temperature of the oven $(T_{oven})$
Dwell time of the plateau $d(t_{op,d})$	Flow rates of inlet gases $(f_{in})$
Number of cycles and plateaus ( <i>m</i> and <i>d</i> )	Composition of inlet gases (x <sub>i,in</sub> )
Rate of current change ( $\Delta I/\Delta t$ )	Current (/)

## **Test Procedure**

- Decrease temperature from the operating one under way to *d* plateau value at its specified rate of change.
- Wait for t<sub>op,d</sub> to elapse and continuously record all TIPs & TOPs at their specified sampling rates, e.g. 1 Hz.
- Continue with the next *d*+1 plateau value until the number *m* of cycles is exhausted.
- Operating periods and/or electrochemical measurements (*j*-V curve and EIS) can be usefully performed between each cycle.
- The test can be interrupted or terminated when operational abnormalities (such as unexpected temperature evolution, signal instabilities) are observed or certain predefined cut-off criteria are fulfilled (threshold values on voltage, temperature or degradation rate).



General evolution of TIPs during TM14 when temperature drops below 600°C with gas and current changes for instance

## **Critical Parameters and Parameter Controls**

• The furnace thermal inertia very often limits the rate of the cooling down process which is then often lower than the heating up rate.

#### When the lowest temperature is below 600°C, H<sub>2</sub> fraction at the negative electrode has to be kept below 4% to avoid explosive atmosphere.

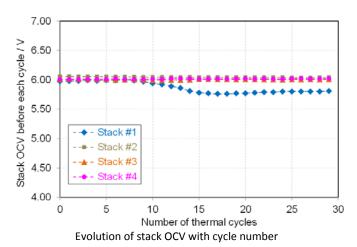
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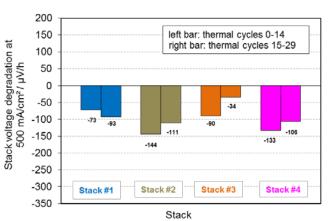
# Main Test Output Parameters (TOPs) and Derived Quantities

TOPs	Derived Quantities
Voltage of cell/RU/stack (V)	Current density (j)
Flow rates of outlet gases (fout)	Gas utilization ( $U_{gas}$ )
Temperature of gas streams at	Degradation rate of
cell/stack inlet/outlet, temperature	cell/RU/stack voltage (ΔV/Δt)
of cell/stack (T)	
Composition of outlet gases $(x_{i,out})$	Average temperature ( $T_{av}$ )

### **Data Post Processing and Representation**

Data representation examples under thermal cycling:





Calculated stack voltage degradation rates at 0.5 A cm<sup>2</sup> (SOFC mode) during thermal cycling

## SOCTESQA:

Solid Oxide Cell and Stack Testing, Safety and Quality Assurance Project website: <u>www.soctesga.eu</u> The research leading to these results has received funding from the European Union Seventh Framework Programme (FP7/2007-2013) for the Fuel Cells and Hydrogen Joint Technology Initiative under grant agreement n° 621245.